Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/739,219	SHIMOYAMA, TAKESHI	
Examiner	**Art Unit**	
Shin-Hon Chen	2131	

SEARCHED			
Class	Subclass	Date	Examiner
			S.C.

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
USPAT, PGPUB, DERWENT, JPO, EPO (BRS search- see search history)	8/22/2007	S.C.